intertek
Total Quality. Assured.

Suzhou Pineapple Health Technology Co., Ltd.

TEST REPORT

SCOPE OF WORK:
EMC directive (2014/30/EU) – EMC report

Model:
BOOSTER MINI

REPORT NUMBER
200500779SHA-001

ISSUE DATE
June 10, 2020

DOCUMENT CONTROL NUMBER
TTRF55014-01_V1

Intertek Testing Services Shanghai,
Building No.86, 1198 Qinzhou Road (North),
Caohejing Development Zone,
Shanghai 200233, China

Telephone: 86 21 6127 8200
www.intertek.com

Report no. 200500779SHA-001

Applicant	:	Suzhou Pineapple Health Technology Co., Ltd. No. 1, Guantang Road, Xiangcheng District, Suzhou, Jiangsu, China
Manufacturer	:	Same as applicant
Manufacturing site	:	Same as applicant

Summary

The equipment complies with the requirements according to the following standard(s) or Specification:

EN 55014-1:2017: Electromagnetic compatibility - Requirements for household appliances, electric tools and similar apparatus Part 1: Emission

EN 55014-2:2015: Electromagnetic compatibility - Requirements for household appliances, electric tools and similar apparatus Part 2: Immunity – Product family standard

EN 61000-3-2:2014: Electromagnetic compatibility (EMC) - Part 3-2: Limits - Limits for harmonic current emissions (equipment input current ≤ 16A per phase)

EN 61000-3-3:2013: Electromagnetic compatibility (EMC) - Part 3-3: Limits - Limitation of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems, for equipment with rated current ≤ 16A per phase and not subject to conditional connection

PREPARED BY:	**REVIEWED BY:**
Hao Liang	Star Guo
Hao Liang Project Engineer	Star Guo Reviewer

Contents

Revision History

Report No.	Version	Description	Issued Date
200500779SHA-001	Rev. 01	Initial issue of report	June 10, 2020

Measurement result summary

TEST ITEM	TEST RESULT	NOTE
Mains terminal continuous disturbance voltage	Pass	
Mains terminal discontinuous disturbance voltage/click	NA	
Continuous disturbance power	Pass	
Radiated Emission	Pass	
Harmonics	Pass	
Voltage fluctuation-Flicker	Pass	
Electrostatic Discharge (ESD)	Pass	
RF electromagnetic field susceptibility	Pass	
Electric Fast Transient /Burst (EFT/B)	Pass	
Surge	Pass	
Injected Current	Pass	
Voltage dips and interruption	Pass	

Notes:

1. NA =Not Applicable
2. Determination of the test conclusion is based on IEC Guide 115 in consideration of measurement uncertainty.
3. Additions, Deviations and Exclusions from Standards: None.

1. GENERAL INFORMATION

1.1 Description of Equipment Under Test (EUT)

Product name	:	Hand held massager
Type/Model	:	BOOSTER MINI
Description of EUT	:	The product covered in this report is a battery-operated hand held massager intended for household indoor use only. The battery is only to be recharged in the product. Charging model and motor operating mode were tested, and the worst data has been listed as representative.
Rating	:	5VDC, 2A, Class III
Brand name	:	BOOSTER
Mains lead	:	(un)shielded, (non)detachable
Data cable	:	none
EUT type	:	☒ Table-top ☐ Floor standing
☐ EUT is toy, defined as		☐ Category A ☐ Category B ☐ Category C ☐ Category D ☐ Category E
Sample received date	:	2020/5/12
Sample Identification No.	:	0200512-63-003
Date of test	:	2020/5/15 – 2020/5/20

1.2 Description of Test Facility

Name	:	Intertek Testing Services Shanghai
Address	:	Building 86, No. 1198 Qinzhou Road(North), Shanghai 200233, P.R. China
Telephone	:	86 21 61278200
Telefax	:	86 21 54262353
The test facility is recognized, certified, or accredited by these organizations	:	CNAS Accreditation Lab Registration No. CNAS L0139 FCC Accredited Lab Designation Number: CN1175 IC Registration Lab CAB identifier.: CN0051 VCCI Registration Lab Registration No.: R-14243, G-10845, C-14723, T-12252 A2LA Accreditation Lab Certificate Number: 3309.02

2. TEST SPECIFICATIONS

2.1 Normative Standards

IEC 61000-4-2:2008: Electromagnetic Compatibility (EMC) – Part 4-2: testing and measurement techniques – electrostatic discharge immunity test

IEC 61000-4-3:2006+A1:2007+A1:2010: Electromagnetic Compatibility (EMC) – Part 4-3: testing and measurement techniques – radiated, radio frequency, electromagnetic field immunity test

IEC 61000-4-4:2012: Electromagnetic Compatibility (EMC) – Part 4-4: testing and measurement techniques – electric fast transient/burst immunity test

IEC 61000-4-5:2014: Electromagnetic Compatibility (EMC) – Part 4-5: testing and measurement techniques – section 5: surge immunity test

IEC 61000-4-6:2013: Electromagnetic Compatibility (EMC) – Part 4-6: testing and measurement techniques – section 6: immunity to conducted disturbance, induced by radio frequency field

IEC 61000-4-11:2004: Electromagnetic Compatibility (EMC) – Part 4-11: testing and measurement techniques –voltage dips, short interruption and voltage variations immunity test

IEC 61000-4-22:2010, Electromagnetic compatibility (EMC) – Part 4-22: Testing and measurement techniques − Radiated emissions and immunity measurements in fully anechoic rooms (FARs)

Note: there are no magnetic sensitive components included in this EUT and magnetic field immunity test according to EN 61000-4-8 is therefore not required.

2.2 Mode of operation during the test

Within this test report, EUT was tested under all available operation models and tested under its rating voltage and frequency. Other voltage and frequency is specified if used.

2.3 Test Peripherals used

Item No	Description	Band and Model	S/No
1	-	-	-

2.4 Record of climatic conditions

Test Item	Temperature (°C)	Relative Humidity (%)	Pressure (Kpa)
Mains terminal continuous disturbance voltage	24	42	NA
Mains terminal discontinuous disturbance voltage/click	NA	NA	NA
Continuous disturbance power	24	42	NA
Radiated Emission	24	42	NA
Harmonics	NA	NA	NA
Voltage fluctuation-Flicker	NA	NA	NA
Electrostatic Discharge (ESD)	24	42	101
RF electromagnetic field susceptibility	24	42	NA
Electric Fast Transient /Burst (EFT/B)	24	42	NA
Surge	24	42	NA
Injected Current	24	42	NA
Voltage dips and interruption	24	42	NA

Notes: NA =Not Applicable

2.5 Instrument list

Conducted Emission/Disturbance Power/Tri-loop Test/CDN method					
Used	Equipment	Manufacturer	Type	Internal no.	Due date
☑	Test Receiver	R&S	ESCS 30	EC 2107	2020-07-14
☑	A.M.N.	R&S	ESH2-Z5	EC 3119	2020-11-10
☑	Absorbing clamp	R&S	MDS 21	EC 2108	2020-06-13
Radiated Emission					
Used	Equipment	Manufacturer	Type	Internal no.	Due date
☑	Test Receiver	R&S	ESIB 26	EC 3045	2020-09-16
☑	Bilog Antenna	TESEQ	CBL 6112D	EC 4206	2020-09-24
ESD					
Used	Equipment	Manufacturer	Type	Internal no.	Due date
☑	ESD generator	TESEQ	NSG 437	EC 4792-4	2021-03-26
EFT/Surge/Voltage Dips					
Used	Equipment	Manufacturer	Type	Internal no.	Due date
☑	Conduct immunity system	EM TEST	UCS 500M6B	EC 2958	2021-03-29
☑	Automatic transformer	EM TEST	MV2616	EC 2957	2021-03-29
Conducted Immunity					
Used	Equipment	Manufacturer	Type	Internal no.	Due date
☑	Signal generator	R&S	SML 01	EC 2338	2020-11-29
☑	Power amplifier	AR	75A250	EC 3043-1	2020-07-14
☑	Attenuator	EM TEST	ATT6/75	EC 3043-3	2021-02-11
☑	CDN	Frankonia	CDN M2M316	EC 5969	2021-02-11
Radiated Immunity					
Used	Equipment	Manufacturer	Type	Internal no.	Due date
☑	Signal generator	R&S	SMR 20	EC 3044-1	2021-01-12
☑	Power amplifier	AR	250W1000B	EC 5818-2	2021-04-13
☑	Log-period antenna	AR	AT 1080	EC 3044-7	2021-03-03
☑	Field meter	AR	FL17000	EC 5818-1	2020-06-09
☑	Power sensor	Keysight	N1914A	EC 5818-3	2021-04-13
Tet Site					
Used	Equipment	Manufacturer	Type	Internal no.	Due date
☑	Shielded room	Zhongyu	-	EC 2838	2021-01-12
☑	Shielded room	Zhongyu	-	EC 2839	2021-01-12

☑	Semi-anechoic chamber	Albatross project	-	EC 3048	2020-06-31
☑	Fully-anechoic chamber	Albatross project	-	EC 3047	2020-06-31
Additional instrument					
Used	Equipment	Manufacturer	Type	Internal no.	Due date
☑	Therom-Hygrograph	ZJ1-2A	S.M.I.F.	EC 3783	2021-03-03
☑	Therom-Hygrograph	ZJ1-2A	S.M.I.F.	EC 3481	2021-01-05
☑	Therom-Hygrograph	ZJ1-2A	S.M.I.F.	EC 3442	2021-01-05
☑	Therom-Hygrograph	ZJ1-2A	S.M.I.F.	EC 3324	2020-09-05
☑	Pressure meter	YM3	Shanghai Mengde	EC 3320	2020-07-14

2.6 Measurement Uncertainty

Measurement	Frequency	Expanded Uncertainty (k=2) (±)
Conducted emission at mains ports	9kHz ~ 150kHz	3.52 dB
	150kHz ~ 30MHz	3.19 dB
Continuous disturbance voltage at telecom ports	150kHz ~ 30MHz	3.64 dB
Continuous disturbance current at telecom ports	150kHz ~ 30MHz	2.62 dB
Mains terminal discontinuous disturbance voltage/click	-	3.76 dB
Continuous disturbance power	30MHz ~ 300MHz	4.35 dB
Radiated Emissions up to 1 GHz	30MHz ~ 1GHz	4.90 dB
Radiated Emissions above 1 GHz	1GHz ~ 6GHz	5.02 dB
	6GHz ~ 18GHz	5.28 dB
Harmonic current emission	-	3.90%
Voltage fluctuations and flicker	-	10.34%
ESD	-	6.65%
Radiated susceptibility	-	2.38%
EFT test at main terminal	-	11.57%
EFT test at signal/telecom terminal	-	11.62%
Surge test at main terminal	-	11.57%
Injected current test at main terminal	-	1.88 dB
Injected current test at unshielded signal terminal	-	3.41 dB
Voltage dips and interruption	-	6.05%

Emission Test

3. Mains/Load/Control Terminal Continuous Disturbance Voltage

Test result: **PASS**

3.1 Terminal Voltage Limits for the frequency range 9kHz to 30MHz

3.1.1 General limits

Frequency range (MHz)	Mains ports		Associated ports			
	Disturbance voltage		Disturbance voltage		Disturbance current	
	Limits dB(μV)		Limits dB(μV)		Limits dB(μV)	
	Quasi-peak	Average	Quasi-peak	Average	Quasi-peak	Average
0.15 ~ 0.5	66 ~ 56 *	66 ~ 56 *	80	70	40 ~ 30 *	30 ~ 20 *
0.5 ~ 5.0	56	56	74	64	30	20
5.0 ~ 30	60	60	74	64		

Notes:

1. * means the limit decreasing linearly with the logarithm of the frequency in the range 0.15MHz to 0.5MHz.
2. If the quasi-peak measurements meet the average limit, the EUT shall be deemed to meet both limits and the measurements using the average detector need not be carried out.

3.1.2 Limits for mains port of tools

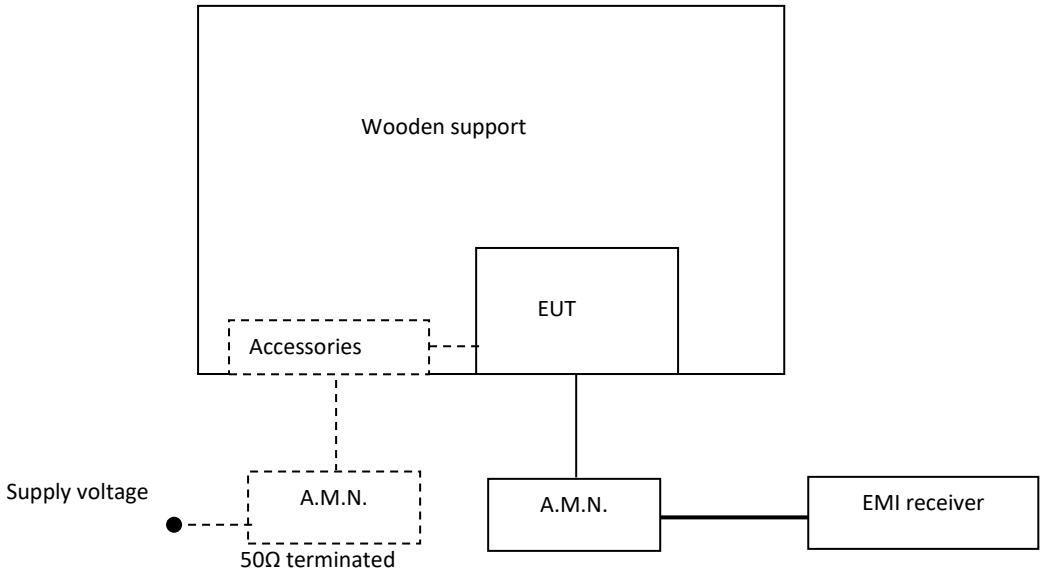
	P ⩽ 700 W		700 W < P ⩽ 1 000 W		P > 1 000 W	
Frequency range (MHz)	Limits dB(μV)		Limits dB(μV)		Limits dB(μV)	
	Quasi-peak	Average	Quasi-peak	Average	Quasi-peak	Average
0.15-0.35	66-59*	59-49*	70-63*	63-53*	76-69*	69 ~ 59 *
0.35-5	59	49	63	53	69	59
5-30	64	54	68	58	74	64

Notes:

1. * means the limit decreasing linearly with the logarithm of the frequency in the range 0.15MHz to 0.35MHz.
2. If the quasi-peak measurements meet the average limit, the EUT shall be deemed to meet both limits and the measurements using the average detector need not be carried out.

3.2 Block Diagram of Test Setup

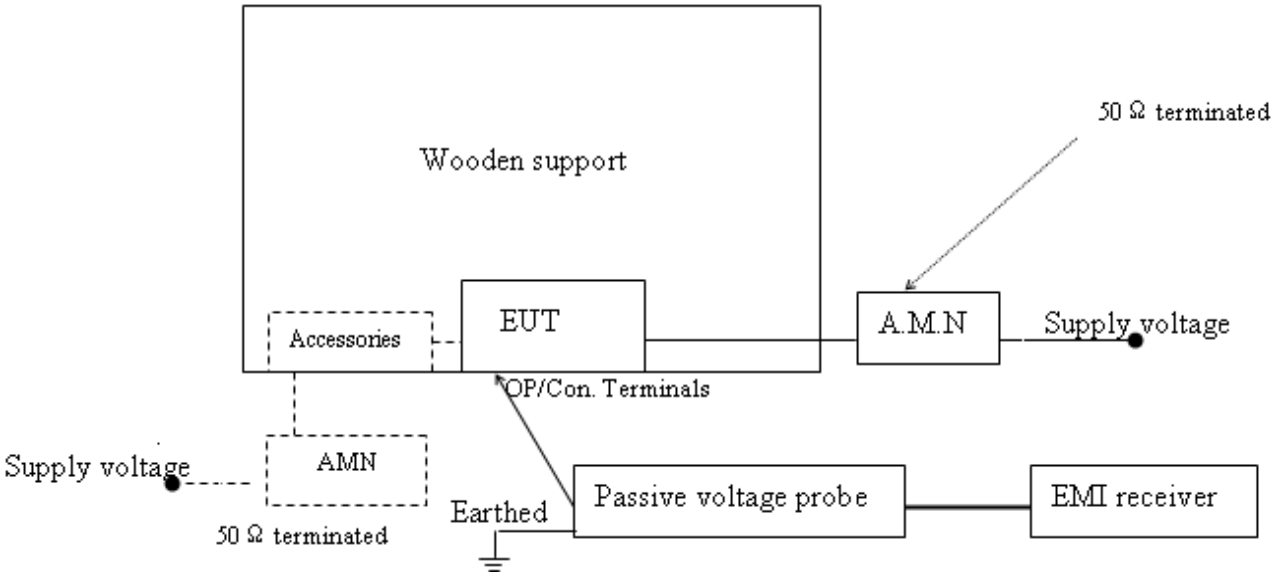
☒ At mains terminal



☒ For table top equipment, wooden support is 0.8m height table

☐ For floor standing equipment, wooden support is 0.1m height rack.

☐ At Associated ports



Note: ——— : power line
——— : signal line
- - - - - - - - : means the test setup while available

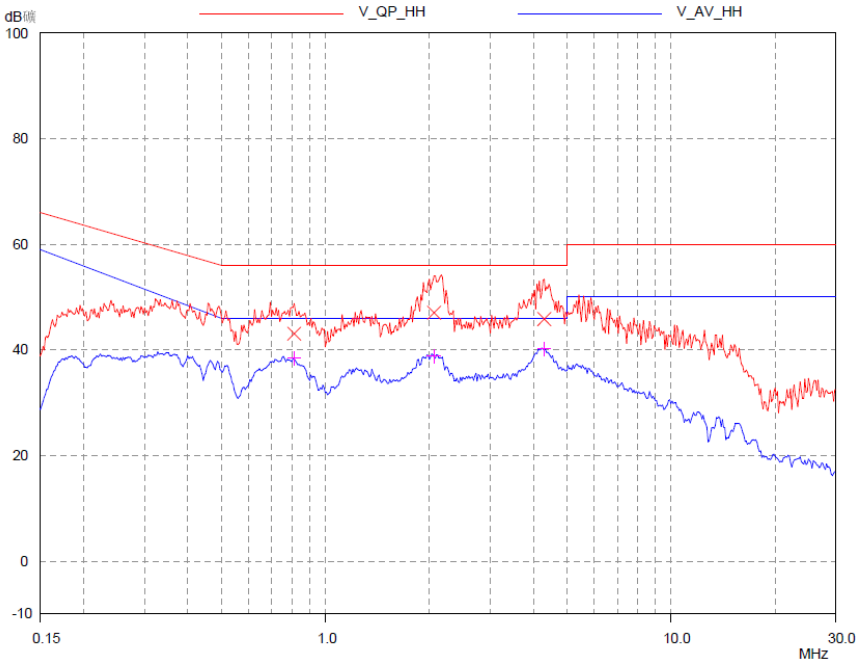
3.3 Test Setup and Test Procedure

Measurement was performed in shielded room, and instruments used were according to clause 5.1 of EN 55014-1 if applicable.
Detailed test procedure and arrangement was according to clause 5.2 of EN 55014-1.
Measurement methods was according to clause 5.4 of EN 55014-1.
Operation conditions of EUT was according to clause 6 of EN 55014-1.
Frequency range 150kHz – 30MHz was checked and EMI receiver measurement bandwidth was set to 9kHz.

3.4 Test Protocol

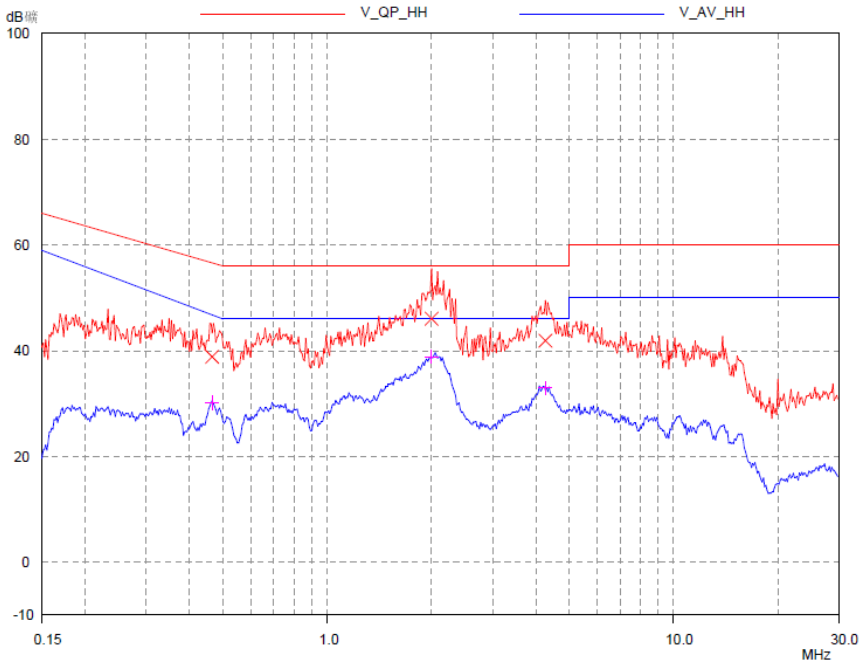
For Mains ports: Pass

L Line:



Frequency (MHz)	Quasi-peak			Average		
	Corrected Reading (dBuV)	Limit (dBuV)	Margin (dB)	Corrected Reading (dBuV)	Limit (dBuV)	Margin (dB)
0.81	43.07	56.00	12.93	38.43	46.00	7.57
2.06	47.04	56.00	8.96	38.84	46.00	7.16
4.30	45.84	56.00	10.16	40.21	46.00	5.79
Note: * means the emission level 20dB below the relevant limit.						

N Line:



Frequency (MHz)	Quasi-peak			Average		
	Corrected Reading (dBuV)	Limit (dBuV)	Margin (dB)	Corrected Reading (dBuV)	Limit (dBuV)	Margin (dB)
0.47	38.86	56.60	17.74	30.16	46.78	16.62
2.00	46.06	56.00	9.94	38.90	46.00	7.10
4.26	41.88	56.00	14.12	32.92	46.00	13.08
Note: * means the emission level 20dB below the relevant limit.						

Remark: 1. Correct Factor = LISN Factor + Cable Loss, the value was added to Original Receiver Reading by the software automatically.
2. Corrected Reading = Original Receiver Reading + Correct Factor
3. Margin = Limit - Corrected Reading
4. If the PK Corrected Reading is lower than AV limit, the AV test can be elided.

Example: Assuming LISN Factor = 10.00dB, Cable Loss = 2.00dB,
Original Receiver Reading = 10.00dBuV, Limit = 66.00dBuV.
Then Correct Factor = 10.00 + 2.00 = 12.00dB;
Corrected Reading = 10dBuV + 12.00dB = 22.00dBuV;
Margin = 66.00dBuV – 22.00dBuV = 44.00dB.

For Associated ports: NA

Frequency (MHz)	Quasi-peak			Average		
	Corrected Reading (dBuV)	Limit (dBuV)	Margin (dB)	Corrected Reading (dBuV)	Limit (dBuV)	Margin (dB)
Note: * means the emission level 20dB below the relevant limit.						

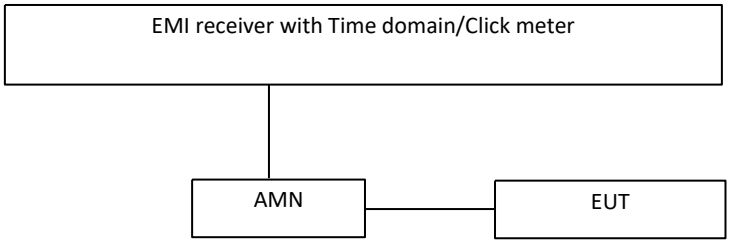
Remark: 1. Correct Factor = LISN Factor + Cable Loss, the value was added to Original Receiver Reading by the software automatically.
2. Corrected Reading = Original Receiver Reading + Correct Factor
3. Margin = Limit - Corrected Reading
4. If the PK Corrected Reading is lower than AV limit, the AV test can be elided.

Example: Assuming LISN Factor = 10.00dB, Cable Loss = 2.00dB,
Original Receiver Reading = 10.00dBuV, Limit = 66.00dBuV.
Then Correct Factor = 10.00 + 2.00 = 12.00dB;
Corrected Reading = 10dBuV + 12.00dB = 22.00dBuV;
Margin = 66.00dBuV – 22.00dBuV = 44.00dB.

4. Mains terminal discontinuous disturbance voltage/click

Test result: NA

4.1 Block Diagram of Test Setup



4.2 Test Setup and Test Procedure

Measurement was performed in shielded room, and instruments used were according to clause 5.1 of EN 55014-1 if applicable.
Detailed test procedure and arrangement was according to clause 5.2 of EN 55014-1.
Measurement methods was according to clause 5.4 of EN 55014-1.
Operation conditions of EUT was according to clause 6 of EN 55014-1.
0.15MHz, 0.5MHz, 1.4MHz and 30MHz were spot checked, and upper quartile methods used during measurement.
The final judgment of test result was according to figure 6 of EN 55014-1.

4.3 Test Protocol

Frequency (MHz)	0.15	0.5	1.4	30.0
Permitted limit for continuous interference (dBµV)	66.0	56.0	56.0	60.0
Counted click/switch operation number				
Observed time (min)				
Click duration (ms)				
Click rate N				
Factor				
Permitted limits for clicks (dBµv)				
Counted clicks exceeding the limits				
Test result				
Any other descriptions:				

5. Continuous disturbance power

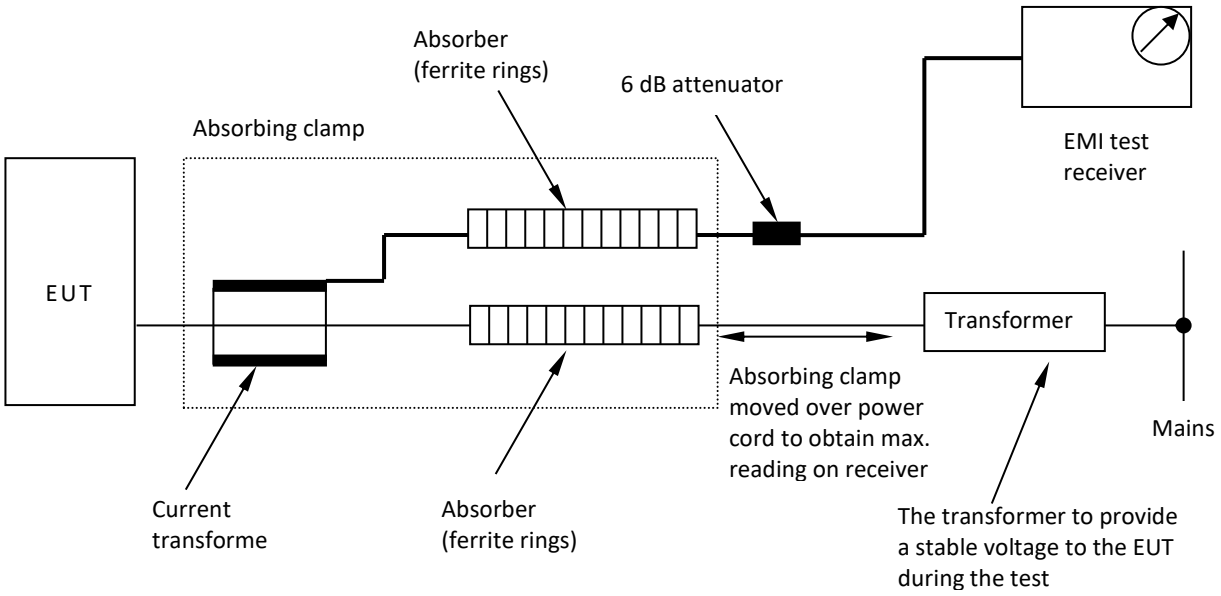
Test result: **PASS**

5.1 Continuous disturbance power limit

	General		P ⩽ 700 W		700 W < P ⩽ 1 000 W		P > 1 000 W	
Frequency range (MHz)	Limits dB(pW) Quasi-peak	Average	Limits dB(pW) Quasi-peak	Average	Limits dB(pW) Quasi-peak	Average	Limits dB(pW) Quasi-peak	Average
30-300	45-55*	35-45*	45-55*	35-45*	49-59*	39-49*	55-65*	45-55*

Notes:
1. * means the limit decreasing linearly with the logarithm of the frequency in the range 30MHz to 300MHz.
2. If the quasi-peak measurements meet the average limit, the EUT shall be deemed to meet both limits and the measurements using the average detector need not be carried out.

5.2 Block diagram of test set up

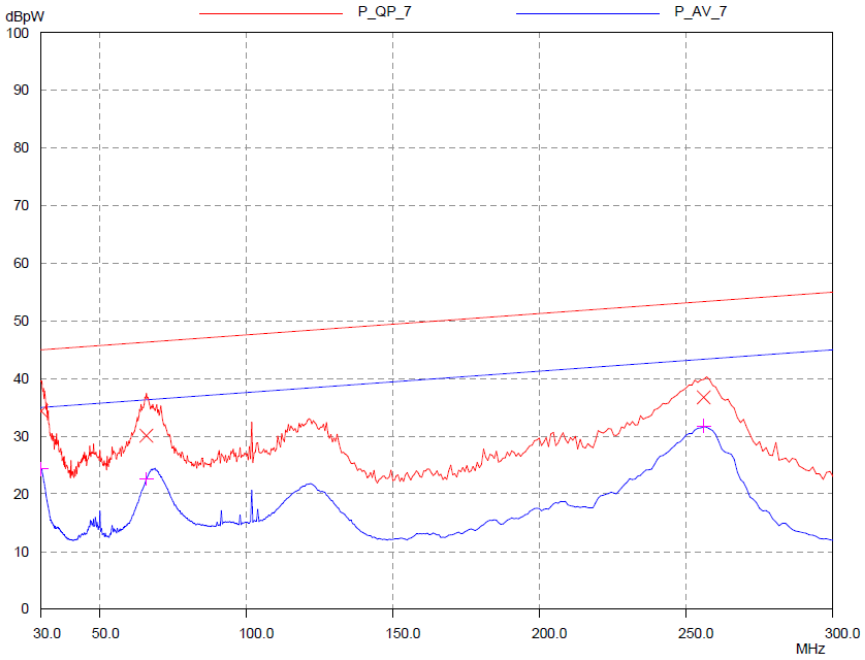


5.3 Test Procedure

Measurement was performed in shielded room, and instruments used were according to clause 5.1 of EN 55014-1 if applicable.
Detailed test procedure and arrangement was according to clause 5.3 of EN 55014-1.
Measurement methods was according to clause 5.4 of EN 55014-1.
Operation conditions of EUT was according to clause 6 of EN 55014-1.
Frequency range 30MHz – 300MHz was checked and EMI receiver measurement bandwidth was set to 120kHz.

5.4 Test Protocol

For Mains ports: Pass



At mains lead

Frequency (MHz)	Quasi-peak		Average	
	Disturbance level dB(pW)	Permitted limit dB(pW)	Disturbance level dB(pW)	Permitted limit dB(pW)
30.0	34.38	45.00	24.37	35.00
65.87	30.12	46.33	22.60	36.33
255.93	36.77	53.37	31.80	43.37
Note: * means the emission level 20dB lower than the relevant limit.				

Remark: 1. Correct Factor = Clamp Factor + Cable Loss, the value was added to Original Receiver Reading by the software automatically.
2. Corrected Reading = Original Receiver Reading + Correct Factor
3. Margin = Limit - Corrected Reading
4. If the PK Corrected Reading is lower than AV limit, the AV test can be elided.

Example: Assuming Clamp Factor = 10.00dB, Cable Loss = 2.00dB,
Original Receiver Reading = 10.00dBpW, Limit = 66.00dBpW.
Then Correct Factor = 10.00 + 2.00 = 12.00dB;
Corrected Reading = 10dBpW + 12.00dB = 22.00dBpW;
Margin = 66.00dBpW – 22.00dBpW = 44.00dB.

For Associated ports: NA

Frequency (MHz)	Quasi-peak			Average		
	Corrected Reading (dBpW)	Limit (dBpW)	Margin (dB)	Corrected Reading (dBpW)	Limit (dBpW)	Margin (dB)
Note: * means the emission level 20dB below the relevant limit.						

Remark: 1. Correct Factor = Clamp Factor + Cable Loss, the value was added to Original Receiver Reading by the software automatically.
2. Corrected Reading = Original Receiver Reading + Correct Factor
3. Margin = Limit - Corrected Reading
4. If the PK Corrected Reading is lower than AV limit, the AV test can be elided.

Example: Assuming Clamp Factor = 10.00dB, Cable Loss = 2.00dB,
Original Receiver Reading = 10.00dBpW, Limit = 66.00dBpW.
Then Correct Factor = 10.00 + 2.00 = 12.00dB;
Corrected Reading = 10dBpW + 12.00dB = 22.00dBpW;
Margin = 66.00dBpW – 22.00dBpW = 44.00dB.

6. Radiated emission

Test result: **PASS**

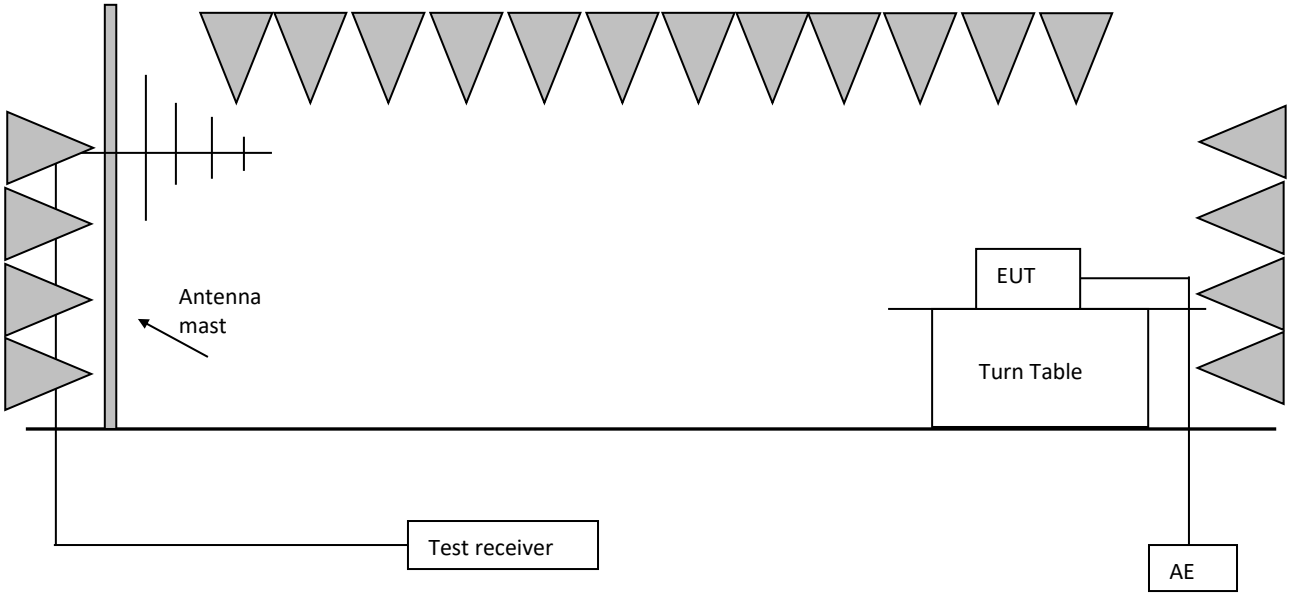
☒ As for in the disturbance power test all emission readings from the EUT are lower than the applicable limits (Table 7) reduced by the margin (Table 8) and the maximum clock frequency is less than 30MHz, the EUT is deemed to comply with the Radiated Emission requirement without test.

6.1 Limit

☐ Radiated emission limit from frequency range 30MHz – 1000MHz

Frequency (MHz)	Permitted limit in dBµV/m (Quasi-peak) of Measurement Distance 3m	Permitted limit in dBµV/m (Quasi-peak) of Measurement Distance 10m
30 ~ 230	40	30
230 ~ 300	47	37
Notes: 1. For the measurement distance other than 3m and 10m, the limit is varied according to 20dB/10 decades. 2. The gray rows are selected items.		

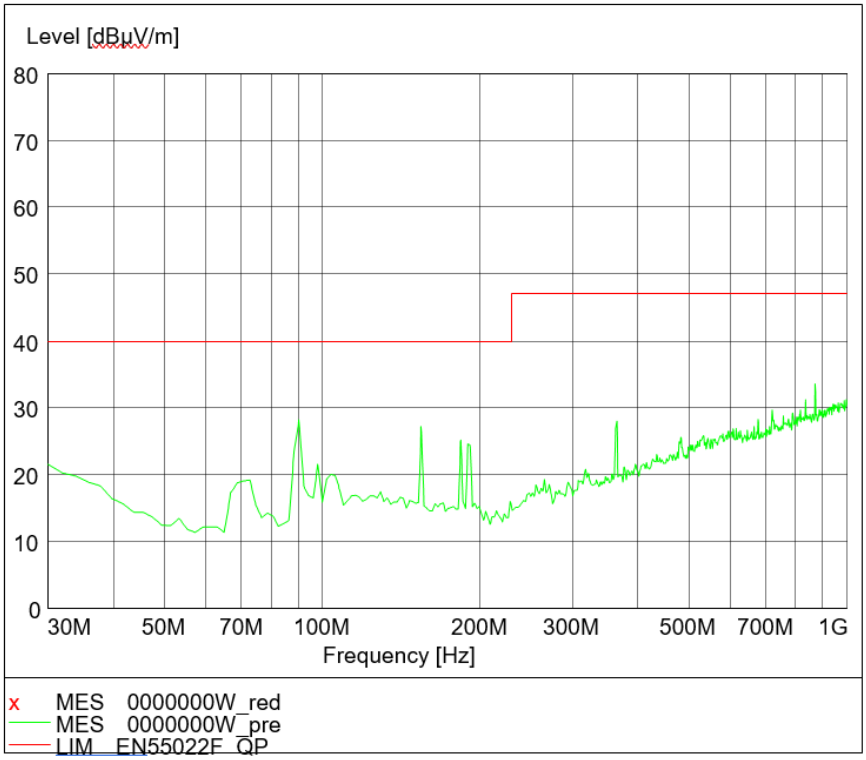
6.2 Block diagram and test set up



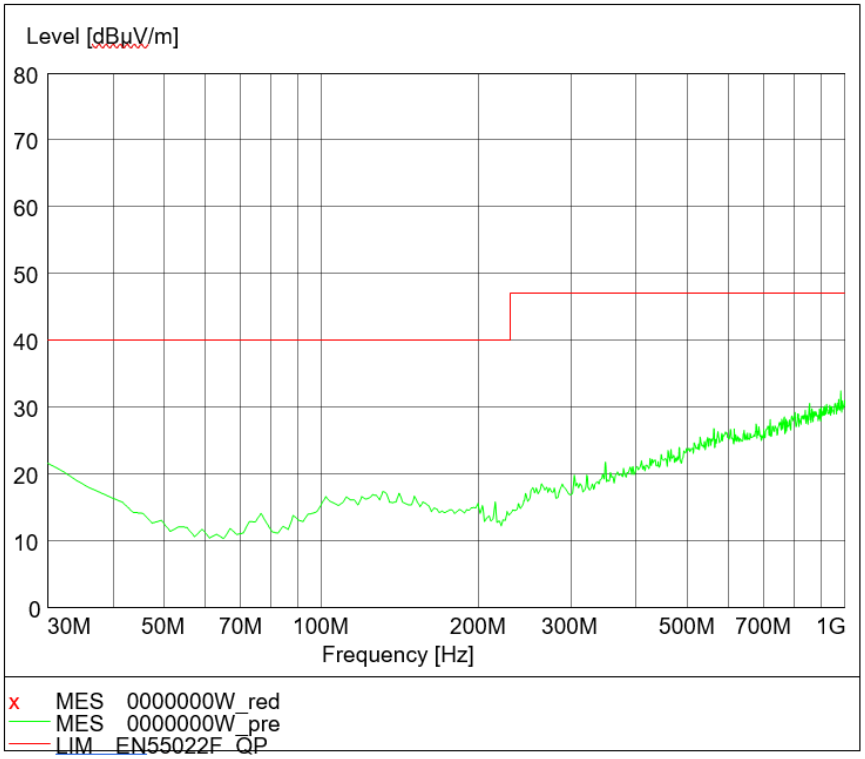
The measurement was applied in a semi-anechoic chamber.
Operation conditions of EUT was according to clause 6 of EN 55014-1.
Measurement was performed according to clause 10 of CISPR 32.
Setting of EUT is according to clause 5.3.4.3 of EN 55014-1.
The bandwidth setting on test receiver was 120kHz.
The frequency range from 30MHz to 300MHz was checked.

6.3 Test Protocol

Horizontal



Vertical



Remark: 1. Correct Factor = Antenna Factor + Cable Loss (+ Amplifier, for higher than 1GHz), the value was added to Original Receiver Reading by the software automatically.

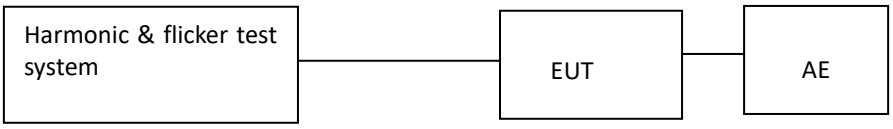
2. Corrected Reading = Original Receiver Reading + Correct Factor
3. Margin = Limit - Corrected Reading
4. If the PK Corrected Reading is lower than AV limit, the AV test can be elided.

Example: Assuming Antenna Factor = 30.20dB/m, Cable Loss = 2.00dB,
Gain of Preamplifier = 32.00dB, Original Receiver Reading = 10.00dBuV,
Limit = 40.00dBuV/m.
Then Correct Factor = 30.20 + 2.00 – 32.00 = 0.20dB/m;
Corrected Reading = 10dBuV + 0.20dB/m = 10.20dBuV/m;
Margin = 40.00dBuV/m - 10.20dBuV/m = 29.80dB.

7. Harmonics

Test result: **PASS**

7.1 Block Diagram of Test Setup



7.2 Test Setup and Test Procedure

Harmonics of the fundamental current were measured up to 40 order harmonics using a digital power meter with an analogue output and frequency analyser which was integrated in the harmonic & flicker test system. The measurements were carried out under steady conditions.

☐ Measuring instrumentation according to IEC 61000-4-7:2002+A1:2008

☒ This product is not defined as lighting equipment, and has rated power less than 75W, therefore, no limit apply according to EN 61000-3-2

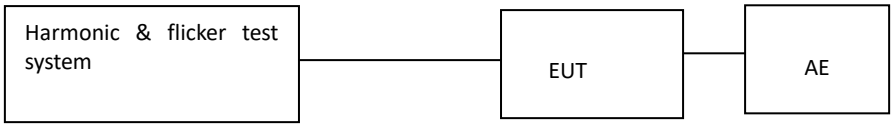
☐ The EUT is kitchen machines as listed in the scope of IEC 60335-2-14, therefore, is deemed to conform to the harmonic current limits of this standard without further testing.

7.3 Test Protocol

8. Voltage Fluctuations-Flicker

Test result: **PASS**

8.1 Block Diagram of Test Setup



8.2 Test Setup and Test Procedure

8.2.1 Definition

Flicker: impression of unsteadiness of visual sensation induced by a light stimulus whose luminance or spectral distribution fluctuates with time.

Pst: Short-term flicker severity.

Plt: long-term flicker severity.

dc: maximum steady state voltage change during an observation period.

dmax: maximum absolute voltage change during an observation period.

d(t): time function of the relative r.m.s. voltage change evaluated as a single value for each successive half period between zero-crossings of the source voltage, except during time interval in which the voltage is a steady-state condition for at least 1s.

8.2.2 Test condition

The EUT was set to produce the most unfavorable sequence of voltage changes.

8.3 Test Protocol

The tested object operated under the operating condition specified in EN 61000-3-3
The following limits apply

- the value of Pst shall not be greater than 1,0.
- the value of Plt shall not be greater than 0,65.
- Tmax, the accumulated time value of d(t) with a deviation exceeding 3,3 % during a single voltage change at the EUT terminals, shall not exceed 500 ms.
- the maximum relative steady-state voltage change, dc, shall not exceed 3,3 %.
- the maximum relative voltage change dmax, shall not exceed:

☐ 4% without additional conditions.
☐ 6 % for equipment which is:
– switched manually, or
– switched automatically more frequently than twice per day, and also has either a delayed restart (the delay being not less than a few tens of seconds), or manual restart, after a power supply interruption.
☐ 7 % for equipment which is:
– attended whilst in use (for example: hair dryers, vacuum cleaners, kitchen equipment such as mixers, garden equipment such as lawn mowers, portable tools such as electric drills), or
– switched on automatically, or is intended to be switched on manually, no more than twice per day, and also has either a delayed restart (the delay being not less than a few tens of seconds) or manual restart, after a power supply interruption.
☐ for manual switch, dmax is measured in accordance with Annex B of standard, average dmax is calculated from 24 times measurement.
☒ The rate power of the EUT is no greater than 75W, which is unlikely to produce significant voltage fluctuations or flicker by technical analysis and evaluation. So it is deemed to fulfil the requirements without testing.

Immunity Test

Performance criteria

The performance criteria are based on the general criteria of the standard and derived from the product specification

Criterion A: Normal Performance within limits specified by the manufacturer, request or purchaser.

Criterion B: Continue to operate as intended after the test. No degradation of performance or loss of function. During the test degradation of performance is allowed, however no change of actual operating state or stored date.

Criterion C: Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls.

Categories of apparatus

☐ Category I (fulfill the relevant immunity requirements without testing)

☒ Category II (Shall fulfill the tests: ESD, EFT, Inject current, Surge, Dips)

☒ Category III (Shall fulfill the tests: ESD, EM fields*)

☐ Category IV (Shall fulfill the tests: ESD, EFT, Inject current, Surge, Dips, EM fields)

Note: *only applicable to the ride on toys operating with electronic devices.

9. Electrostatic Discharge (ESD)

Test result: **PASS**

9.1 Severity Level and Performance Criterion

9.1.1 Test level

1a – Contact discharge		1b – Air discharge	
Level	Test voltage kV	Level	Test voltage kV
1	2	1	2
2	4	2	4
3	6	3	8
4	8	4	15
X	Special	X	Special

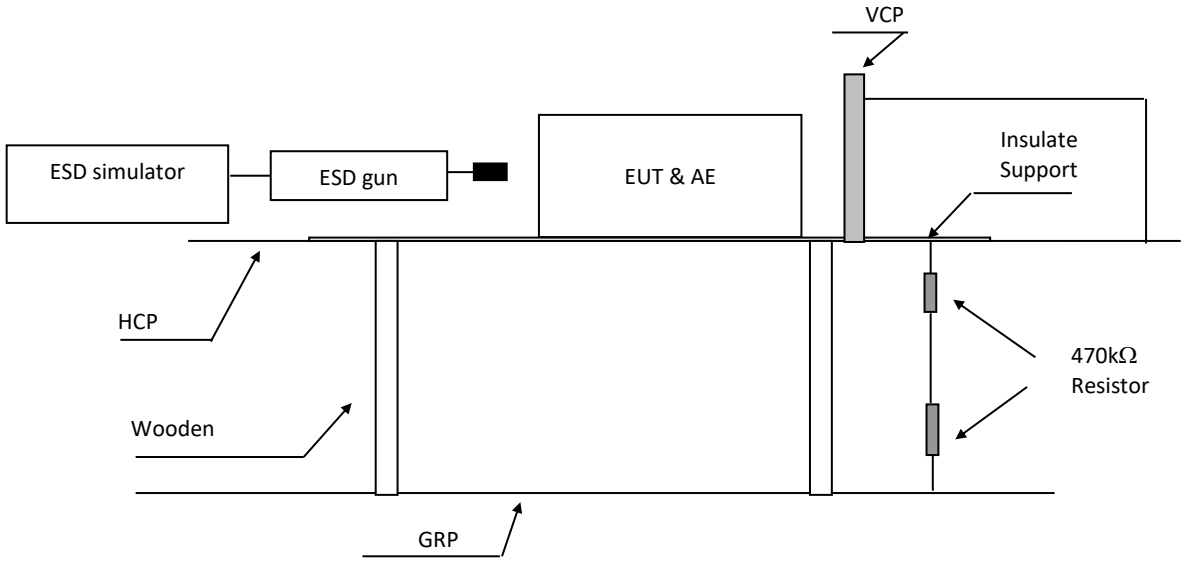
Notes:
1."X" is an open level. The level has to be specified in the dedicated equipment specification. If higher voltages than those shown are specified, special test equipment may be needed.
2. The gray rows were the selected test level.

9.1.2 Performance Criterion

Performance criterion: **B**

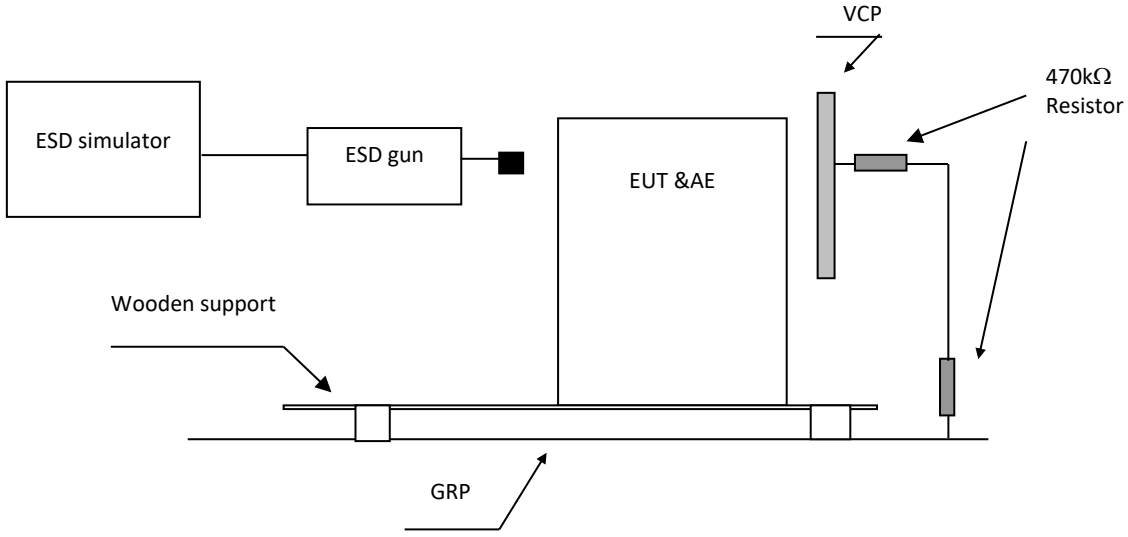
9.2 Block Diagram of Test Setup

☒ For table-top equipment



Note: HCP means Horizontal Coupling Plane
VCP means Vertical Coupling Plane
GRP means Ground Reference Plane
Wooden support is a 0.8m height table

☐ For floor standing equipment



Note: VCP means Vertical Coupling Plane
GRP means Ground Reference Plane
Wooden support is a 0.1m height rack

9.3 Test Setup and Test Procedure

Measurement was performed in shielded room.
Measurement and setting of EUT was applied according to IEC 61000-4-2 Clasuse 7.
The test method and equipment was specified by IEC 61000-4-2 with the modifications by EN 55014-2 clause 5.1.

9.4 Test Protocol

Direct discharges were applied at the following selected points:

Test point #	Test level [kV]	Air/ Contact	Polarity (+/-)	Pass/Fail/NA	Comment
A	2/4	Contact	+/-	Pass	All touchable screws of enclosure
B	2/4	Contact	+/-	Pass	Accessible metal parts of the EUT
C	2/4/8	Air	+/-	Pass	Air gap of the switch, button
D	2/4/8	Air	+/-	Pass	The air in-taking opening
E	2/4/8	Air	+/-	Pass	Slots around the EUT

Indirect contact discharges were applied to the VCP and the HCP at the following selected points:

☒ For table top equipment

Point	Description	Point	Pass/Fail/NA
HCP f	0,1m from the front of the EUT	Edge of centre, corner on HCP	Pass
HCP b	0,1m from the back of the EUT	Edge of centre, corner on HCP	Pass
HCP r	0,1m from the right side of the EUT	Edge of centre, corner on HCP	Pass
HCP l	0,1m from the left side of the EUT	Edge of centre, corner on HCP	Pass
VCP f	0,1m from the front of the EUT	Edge of centre, corner on VCP	Pass
VCP b	0,1m from the back of the EUT	Edge of centre, corner on VCP	Pass
VCP r	0,1m from the right of the EUT	Edge of centre, corner on VCP	Pass
VCP l	0,1m from the left of the EUT	Edge of centre, corner on VCP	Pass

☐ For floor standing equipment

Point	Description	Point	Pass/Fail/NA
VCP f	0,1m from the front of the EUT	Edge of centre, corner on VCP	-
VCP b	0,1m from the back of the EUT	Edge of centre, corner on VCP	-
VCP r	0,1m from the right of the EUT	Edge of centre, corner on VCP	-
VCP l	0,1m from the left of the EUT	Edge of centre, corner on VCP	-

Observation: All the functions were operated as normal during and after test.
Conclusion: The EUT met the requirements of Performance Criterion B.

10. Electromagnetic field susceptibility

Test result: **PASS**

10.1 Severity Level and Performance Criterion

10.1.1 Test level

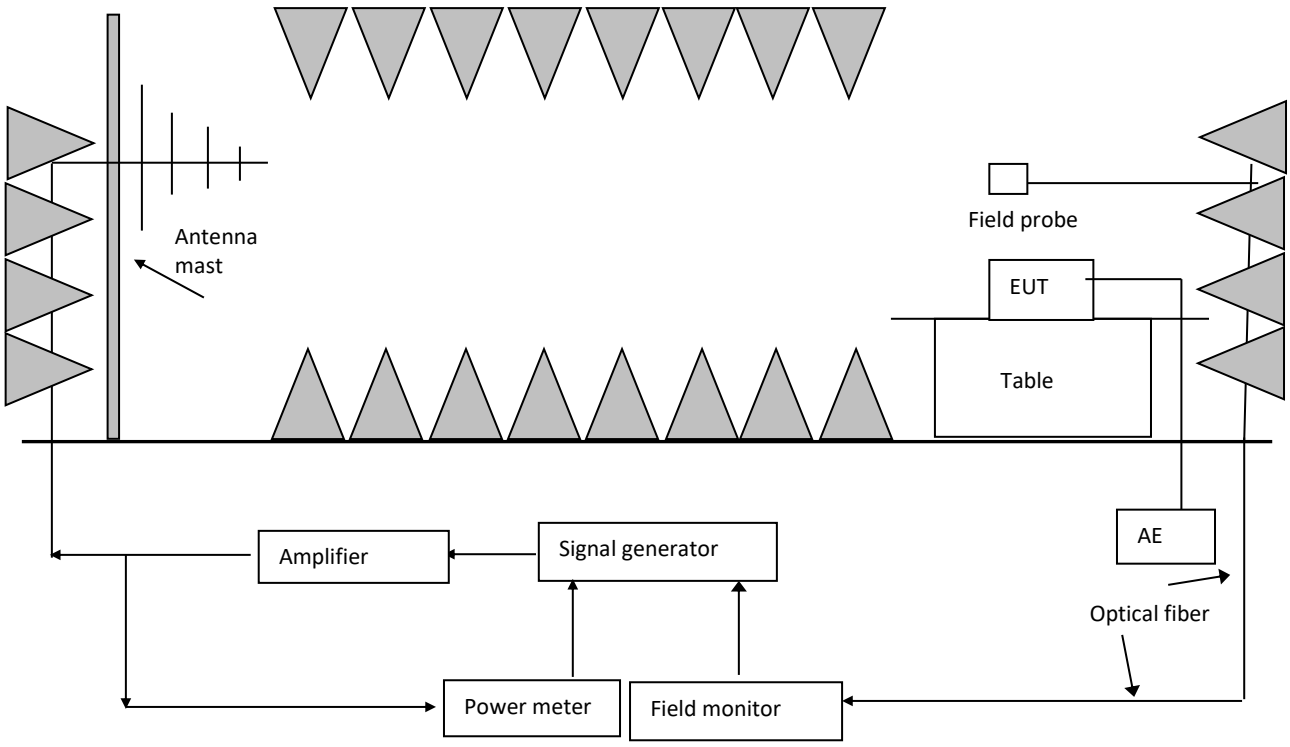
Level	Test field strength V/m
1	1
2	3
3	10
X	Special

Notes:
1. X is an open test level. This level may be given in the product specification.
2. The gray row is the selected test level.

10.1.2 Performance Criterion

Performance criterion: **A**

10.2 Block diagram of test setup



10.3 Test Setup and Test Procedure

Measurement was performed in full-anechoic chamber.
Measurement and setting of EUT was applied according to IEC 61000-4-3 clause 7.
The test method and equipment was specified by IEC 61000-4-3 with additions and modifications by EN 55014-2 clause 5.5.

10.4 Test Protocol

Test no.:	Frequency (MHz)	Polarization	Test level V/m	Modulation	Exposed location	Pass/Fail/NA
1	80-1000	H & V	3	1kHz, 80%, SW, AM, 1% step size	All sides	Pass

Observation: All the functions were operated as normal during and after test.
Conclusion: The EUT met the requirements of Performance Criterion A.

11. Electric Fast Transient/Burst Immunity Test

Test result: **PASS**

11.1 Severity Level and Performance Criterion

11.1.1 Test level

Open circuit output test voltage (±10%) and repetition rate of the impulses (±20%)				
Level	Input and output a.c. power ports		Input and output d.c. power ports Signal lines and control lines ports	
	Voltage peak kV	Repetition rate kHz	Voltage peak kV	Repetition rate kHz
1	0.5	5	0.25	5
2	1	5	0.5	5
3	2	5	1	5
4	4	5	2	5
X	Special	Special	Special	Special
Notes : 1. “X” is an open level. The level has to be specified in the dedicated equipment specification. 2. The gray rows were the selected test level.				

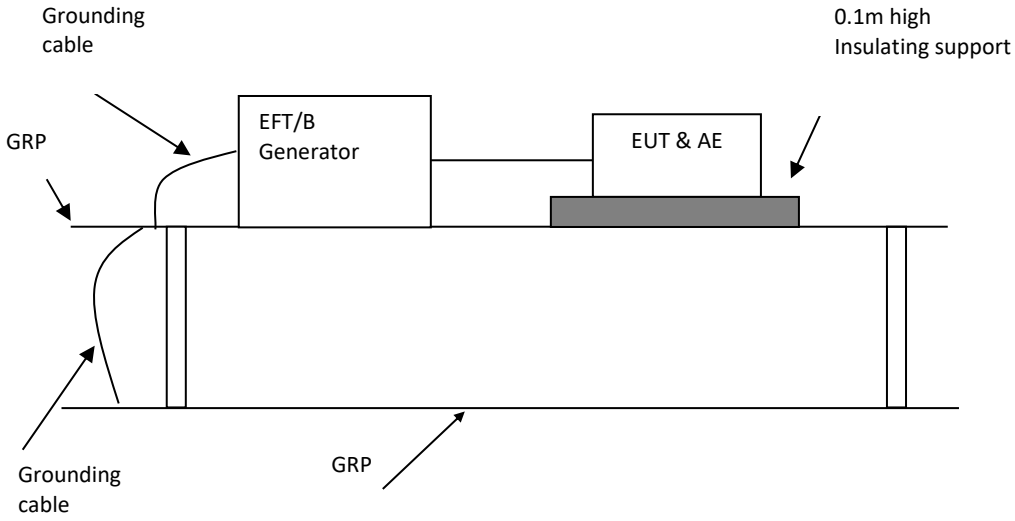
11.1.2 Performance Criterion

Performance criterion **B**

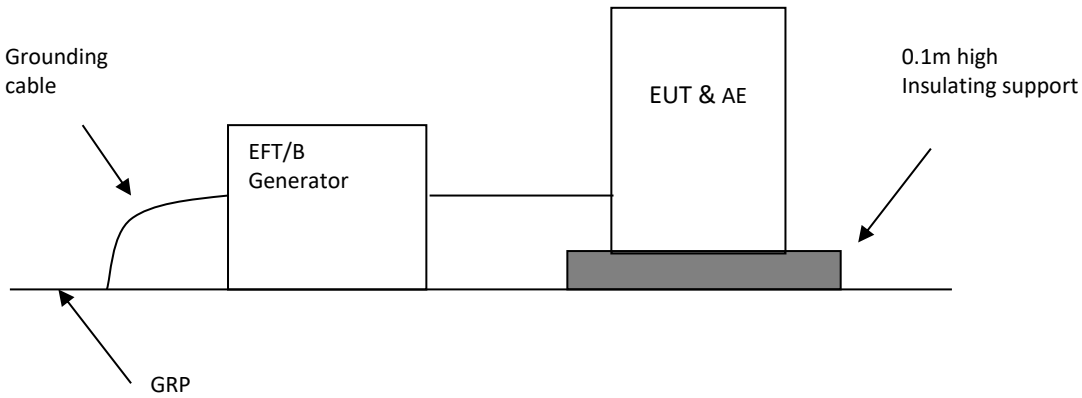
11.2 Block Diagram of Test Setup

11.2.1 Block Diagram for input a.c./d.c. power line

☒ For table-top equipment

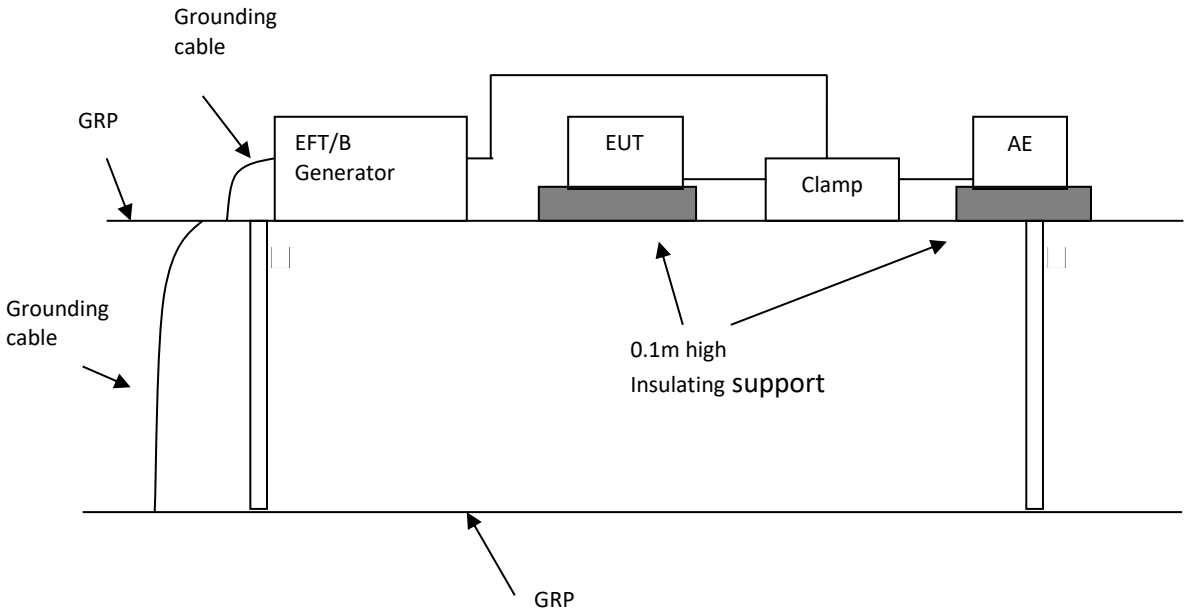


☐ For floor standing equipment

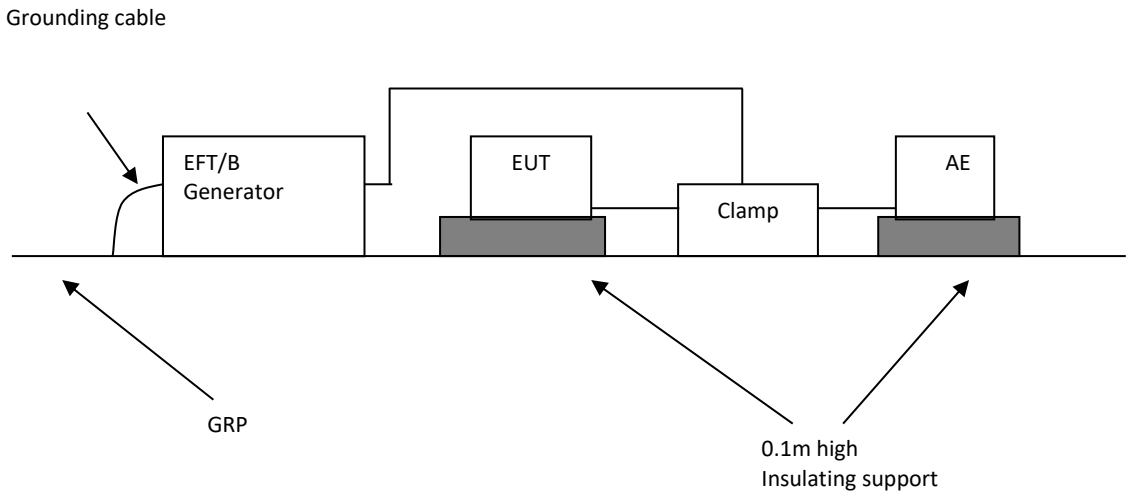


11.2.2 Block Diagram for output a.c./d.c. power line or signal/control lines

☐ For table-top equipment



☐ For floor standing equipment



11.3 Test Setup and Test Procedure

Measurement was performed in shielded room.
Measurement and setting of EUT was applied according to IEC 61000-4-4 clause 7.
The test method and equipment was specified by IEC 61000-4-4 with additions and modifications by EN 55014-2 clause 5.2.

11.4 Test Protocol

Test No.	Level [kV]	Polarity +/-	Repetition rate kHz	Line for test	Pass/Fail/NA
1	1	+/-	5	a.c. power ports	Pass
2	0.5	+/-	5	d.c. power ports	NA
3	0.5	+/-	5	Signal lines and control lines	NA

Observation: All the functions were operated as normal during and after test.
Conclusion: The EUT met the requirements of Performance Criterion B.

12. Surge Immunity Test

Test result: **PASS**

12.1 Severity Level and Performance Criterion

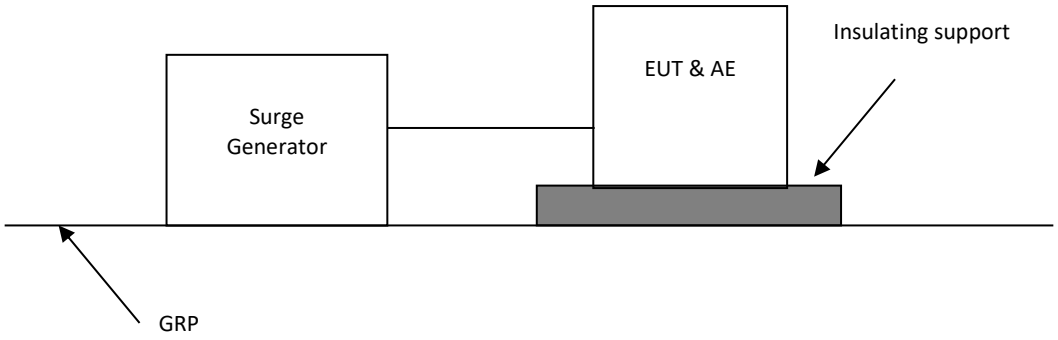
12.1.1 Test level

Level	Open-circuit test voltage ±10% kV
1	0.5
2	1.0
3	2.0
4	4.0
X*	Special
Notes: 1.”X” is an open class. This level can be specified in the product Specification 2. The gray rows are the selected level.	

12.1.2 Performance Criterion

Performance criterion **B**

12.2 Block Diagram of Test Setup



12.3 Test Setup and Test Procedure

Measurement was performed in shielded room.
Measurement and setting of EUT was applied according to IEC 61000-4-5 clause 7.
The test method and equipment was specified by IEC 61000-4-5 with modifications by EN 55014-2 clause 5.6.

12.4 Test Protocol

Test No.	Level [kV]	Polarity +/-	Angle	Line for test	Pass/Fail/NA
1	1	+	90^0	a.c. Mains (line to earth)	NA
2	1	-	270^0	a.c. Mains (line to earth)	NA
3	1	+	90^0	a.c. Mains (line to line)	Pass
4	1	-	270^0	a.c. Mains (line to line)	Pass
5	2	+	90^0	a.c. Mains (line to earth)	Pass
6	2	-	270^0	a.c. Mains (line to earth)	Pass

Observation: All the functions were operated as normal during and after test.
Conclusion: The EUT met the requirements of Performance Criterion B.

13. Immunity to Conducted Disturbances, Induced by Radio-frequency Fields

Test result: **PASS**

13.1 Severity Level and Performance Criterion

13.1.1 Test level

Frequency range 150kHz – 80MHz		
Level	Voltage level (e.m.f.) U_0 [dB(uV)]	U_0 (V)
1	120	1
2	130	3
3	140	10
X	Special	Special
Notes: 1. "X" is an open level. 2. The gray row is the selected test level.		

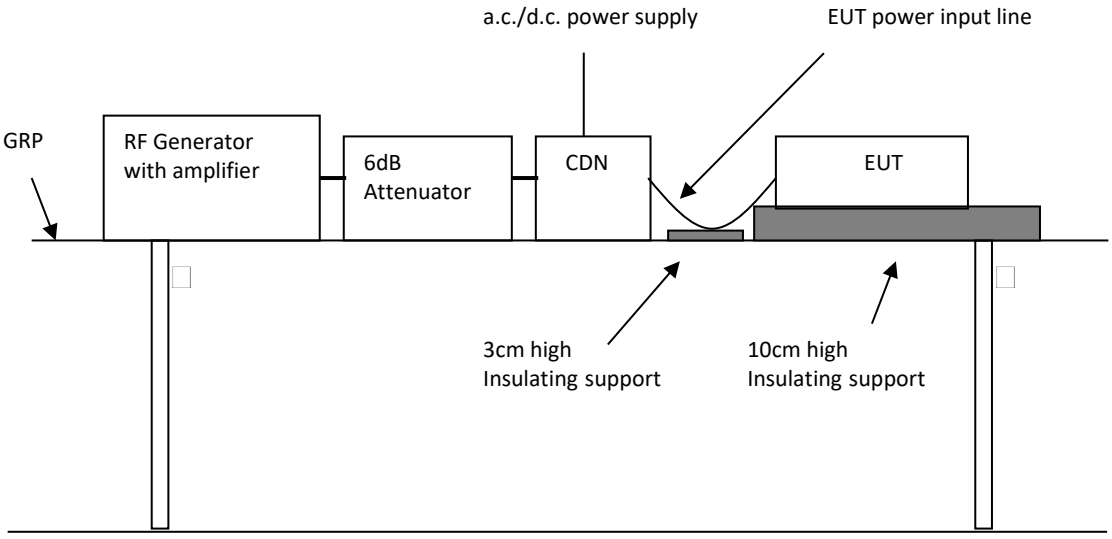
13.1.2 Performance Criterion

Performance criterion: **A**

13.2 Block Diagram of Test Setup

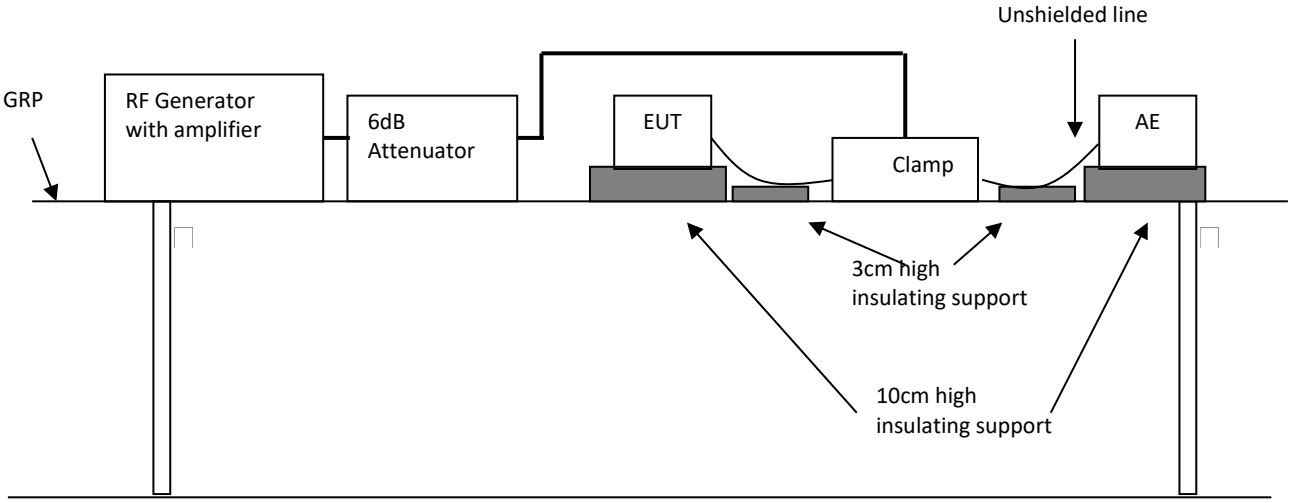
13.2.1 Block Diagram for a.c./d.c input power line

☒ Block Diagram for a.c./d.c input power line

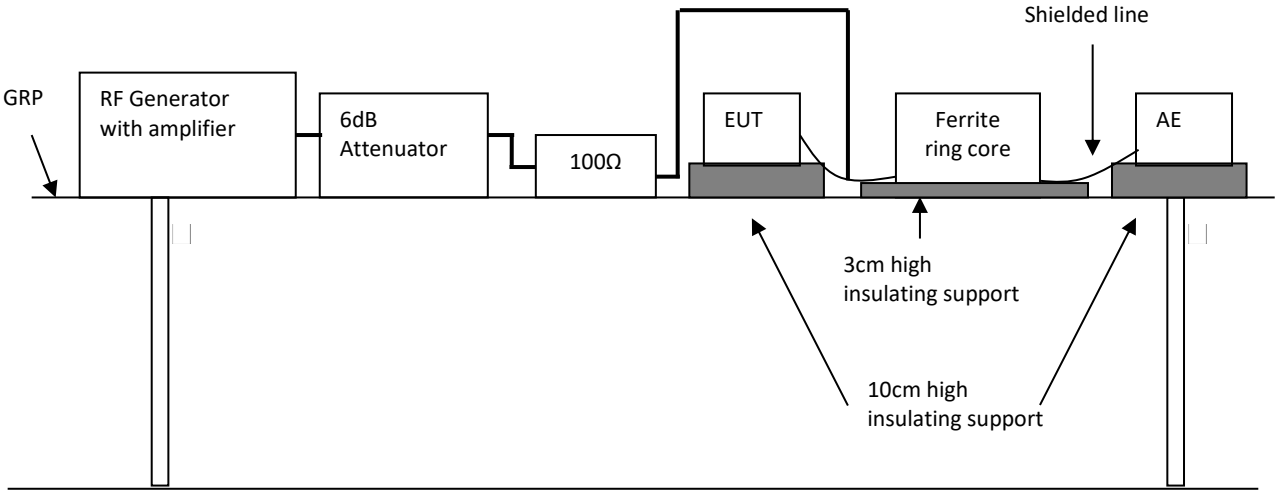


13.2.2 Block Diagram for output a.c./d.c. power line or signal/control lines

☐ Unshielded line



☐ Shielded line



13.3 Test Setup and Test Procedure

Measurement was performed in shielded room.
Measurement and setting of EUT was applied according to IEC 61000-4-6 clause 7.
The test method and equipment was specified by IEC 61000-4-6 with additions and modifications by EN 55014-2 clause 5.3, 5.4.

13.4 Test Protocol

☒ EUT is not required for electromagnetic susceptibility

Test No.	Frequency (MHz)	Level V (r.m.s.)	Modulation	Injected point	Pass/Fail/NA
1	0.15~230	3	1kHz, 80%, SW, AM, 1% step size	a.c. power ports	Pass
2	0.15~230	1	1kHz, 80%, SW, AM, 1% step size	d.c. power ports	-
3	0.15~230	1	1kHz, 80%, SW, AM, 1% step size	signal lines and control lines	-

☐ For EUT test Electromagnetic field susceptibility

Test No.	Frequency (MHz)	Level V (r.m.s.)	Modulation	Injected point	Pass/Fail/NA
1	0.15~80	3	1kHz, 80%, SW, AM, 1% step size	a.c. power ports	NA
2	0.15~80	1	1kHz, 80%, SW, AM, 1% step size	d.c. power ports	-
3	0.15~80	1	1kHz, 80%, SW, AM, 1% step size	signal lines and control lines	-

Observation: All the functions were operated as normal during and after test.
Conclusion: The EUT met the requirements of Performance Criterion A.

14. Voltage Dips, Short Interruptions and Voltage Variations Immunity Test

Test result: **PASS**

14.1 Severity Level and Performance Criterion

14.1.1 Test level

Test level % U_T	Voltage dip and short interruptions % U_T	Duration (in period)	
		50Hz	60Hz
0	100	0.5 cycle	0.5 cycle
40	60	10 cycles	12 cycles
70	30	25 cycles	30 cycles

Notes:

1.“*” for 0.5 period, the test shall be made in positive and negative polarity, i.e. starting at 0° and 180°, respectively.

2. “**” means “x” is an open duration. This duration can be given in the product specification. Utilities in Europe have measured dips and short interruptions of duration between ½ a period and 3000 periods, but duration less than 50 periods are most common.

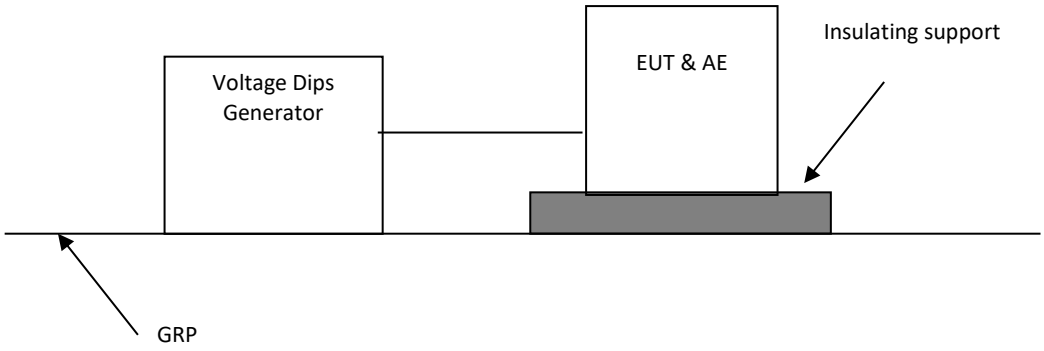
3. If the EUT is tested for voltage dips of 100%, it is generally unnecessary to test for other levels for the same durations. However, for some cases (safeguard systems or electro-mechanical devices) it is not true. The product specification or product committee shall give an indication of the applicability of this note.

4. The gray rows are selected test level.

14.1.2 Performance Criterion

Performance criterion: **C**

14.2 Block diagram of test setup



14.3 Test Setup and Test Procedure

Measurement was performed in shielded room.
Measurement and setting of EUT was applied according to IEC 61000-4-11 clause 7.
The test method and equipment was specified by IEC 61000-4-11 with additions and modifications by EN 55014-2 clause 5.7.

14.4 Test Protocol

Test no.	% U_T	Voltage dip and short interruptions % UT	Duration (in periods)	Pass/Fail/NA
1	70	30%	25 cycles at 50Hz	Pass
			30 cycles at 60Hz	NA
2	40	60%	10 cycles at 50Hz	Pass
			12 cycles at 60Hz	NA
3	0	100% pos half cycle	0.5 cycle at 50Hz	Pass
			0.5 cycle at 60Hz	NA
4	0	100% neg half cycle	0.5 cycle at 50Hz	Pass
			0.5 cycle at 60Hz	NA

Observation: At test level of 40% and 70%, the EUT worked unsteadily. Once the interference is removed, it recovered its normal mode at once.
Conclusion: The EUT met the requirements of Performance Criterion B.

Appendix I: Photograph of equipment under test

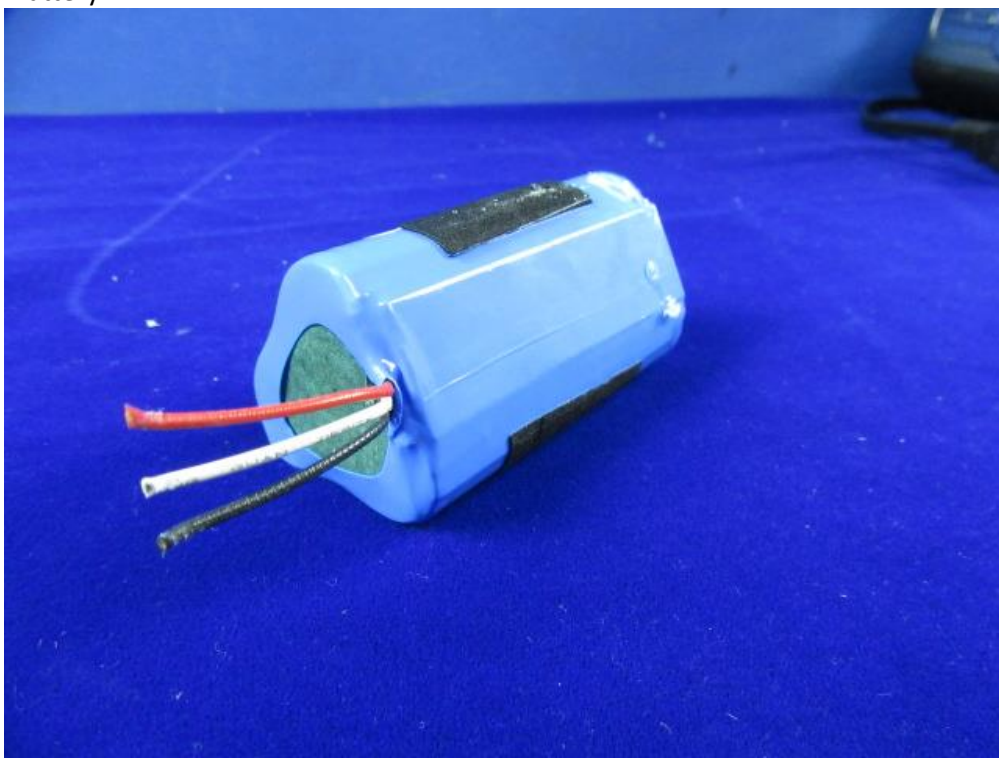
Photo 1.
Description: Overall view

Photo 2.
Description: Overall view

Photo 3.
Description: Switch button (Push on/Push off)

Photo 4.
Description: Internal view

Photo 5.
Description: Battery



END of the report